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Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	0	((pattern with correct\$3 with mask with semiconductor) and (variable same correct\$3 same line same width same overlap\$4 same grid same misalignment)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:12
S2		((pattern with correct\$3 with mask with semiconductor) and (variable same correct\$3 same line same width same overlap\$4 same misalignment)). clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:11
S3	0	((variable same correct\$3 same line same width same overlap\$4 same misalignment)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:11
S4	0	((variable same line same width same overlap\$4 same misalignment)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:11
S5	0	((pattern with correct\$3 with mask with semiconductor) and (line same width same overlap\$4)).clm.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON _.	2007/09/17 17:21
S6	24296	382/144,145,147.ccls. 438/16,401, 462,800.ccls. 716/2,19,20,21.ccls. 356/237.4,237.5,394.ccls. 430/4,5,30. ccls. 700/96,97,105,120,121.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2007/09/18 11:58
S7	373	((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:31

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S8	82	S6 and S7	US-PGPUB;	OR	ON	2007/09/17 17:27
	·		USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB			
S9	4484	((semiconductor or wafer or mask or IC) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:33
S10	100	S6 and S9	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:31
S11	119	((semiconductor or wafer or mask or IC) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4 same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:35
S12	4	S6 and S11	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:35
S13		((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same overlap\$4 same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR ·	ON	2007/09/17 17:36
S14		((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same width same overlap\$4 same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:35

EAST Search History

S15	35	((pattern with mask) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same (overlap\$4 or join\$3 or connect\$3 or overlay\$3 or intersect\$3) same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:37
S16	774	((semiconductor or wafer or mask or IC) and ((correct\$3 or fix\$3 or chang\$3 or adjust\$3) same line same width same (overlap\$4 or join\$3 or connect\$3 or overlay\$3 or intersect\$3) same (misalign\$3 or askew or skew\$3 or uneven or asymmetric\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON .	2007/09/17 17:38
S17	8	S6 and S16	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/09/17 17:38



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((((semiconductor or wafer or mask or ic) and ((correct* or fix* or chang* or adjust*) <paragraph> line <paragraph> width

#3 <paragraph> (overlap* or join* or connect* or overlay* or intersect*) <paragraph> (misalign* or askew or skew* or uneven or asymmetric*))))<in>metadata)

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IEEE STD IEEE Standard		Volume 48, <u>Issue 3,</u> Part 1, June 2001 Page(s):520 - 523 Digital Object Identifier 10.1109/23.940110				
	•	AbstractPlus References Full Text: PDF/76 KR) IEEE INI				

2. Driving spectral resolution to the noise limit in semiconductor gamma de Lachish, U.;

Nuclear Science Symposium Conference Record, 2000 IEEE Volume 2, 15-20 Oct. 2000 Page(s):9/175 - 9/178 vol.2 Digital Object Identifier 10.1109/NSSMIC.2000.949893 AbstractPlus | Full Text: PDF(224 KB) IEEE CNF

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Inventor Name Search Result

Your Search was:

Last Name = HASHIMOTO

First Name = KOJI

Application#	Patent#	Status	Date Filed	Title	Inventor Name
<u>06724592</u>	Not Issued	161	04/18/1985	METHODS FOR PREPARATION OF OVERLAID METAL LAYERS	
06837812	Not Issued	166	03/10/1986	HIGHLY CORROSION- RESISTANT AND HIGH STRENGTH ALUMINUM ALLOYS	НАЅНІМОТО, КОЛ
<u>06838651</u>	Not Issued	166	03/11/1986	HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY	HASHIMOTO, KOJI
<u>06844902</u>	Not Issued	166		HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY	НАЅНІМОТО, КОЈІ
<u>06861371</u>	4772773	150	02/18/1986	METHODS FOR PREPARATION OF OVERLAID AMORPHOUS ALLOY LAYERS	НАЅНІМОТО, КОЈІ
06892827	4770949	150	08/04/1986	SURFACE ACTIVATED AMORPHOUS AND SUPERSATURATED SOLID SOLUTION ALLOYS FOR ELECTRODES IN THE ELECTROLYSIS OF SOLUTIONS AND THE METHOD FOR THEIR SURFACE ACTIVATION	HASHIMOTO, KOJI
07098387	Not Issued	166	1	SURFACE ACTIVATED SURFACE ALLOY ELECTRODES AND A PROCESS FOR PREPARING THEM	HASHIMOTO, KOJI
07098391	4834806	150		CORROSION- RESISTANTSTROCTURE STRUCTURE COMPRISING A METALLK SURFACE AND AN SURFACE BONDED THEREEUPON	HASHIMOTO, KOJI

07162987	07099371	4743314	150	09/21/1987	HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY OF NI-CU-TI WITH TA AND/OR NB	НАЅНІМОТО, КОЛ
RESISTANT AMORPHOUS ROJI	07162987	4877574	150	03/02/1988	FOR CONTROLLING POWER OF NATURAL CIRCULATION	i -
Issued	<u>07183553</u>	4880482	250	04/19/1988	RESISTANT AMORPHOUS	· ·
AND HIGHLY ACTIVE ELECTRODE MADE OF THIS CATALYST	07183981	11 1	166	04/20/1988		· 1
Issued RESISTANT AND HIGH-STRENGTH ALUMINUM ALLOYS	07195732	4868073	150	05/16/1988	AND HIGHLY ACTIVE ELECTRODE MADE OF THIS) 11
CORROSION OF A MATERIAL AGAINST HYDROCHLORIC ACID O7306264 Not Issued O7339611 Not Issued O7420903 5015352 150 10/13/1989 PREPARATION METHOD FOR AMORPHOUS SUPERLATTICE ALLOYS O7440592 5087401 150 11/22/1989 PROCESS FOR PREPARING POLYESTER FILAMENTARY MATERIAL O7453966 Not Issued O7453966 Not Issued	07236262	fl . I	161	08/23/1988	RESISTANT AND HIGH- STRENGTH ALUMINUM	'
Issued	07275642	4968363	250	11/22/1988	CORROSION OF A MATERIAL AGAINST HYDROCHLORIC	
Issued HIGH CORROSION RESISTANCE	07306264		166	02/01/1989	RESISTANT AMORPHOUS	II ' I
AMORPHOUS SUPERLATTICE KOJI	<u>07339611</u>	II i	166	02/24/1989	HIGH CORROSION	·
O7440592 S087401 150 11/22/1989 PROCESS FOR PREPARING POLYESTER FILAMENTARY MATERIAL HASHIMOTO, KOJI	07420903	5015352	150	10/13/1989	AMORPHOUS SUPERLATTICE	·
O7453966 Not Issued Issued Issued Issued For Preparing Them	07420930	5076865	250	10/13/1989		i ' I
Issued SURFACE ALLOY ELECTRODES AND A PROCESS FOR PREPARING THEM	07440592	5087401	150	11/22/1989	POLYESTER FILAMENTARY	·
07/5//12 5020200 250 12/21/1000 ANODDITOTIC AT TRADUBLE TELESTRESCED	07453966		161	12/20/1989	SURFACE ALLOY ELECTRODES AND A PROCESS	1
07454412 5030300 250 12/21/1989 AMORPHOUS ALUMINUM HASHIMOTO, KOJI	07454412	5030300	250	12/21/1989	AMORPHOUS ALUMINUM ALLOYS	HASHIMOTO, KOJI

07481718	4964967	150	02/16/1990	SURFACE ACTIVATED ALLOY ELECTRODES AND PROCESS FOR PREPARING THEM	HASHIMOTO, KOJI
07529727	Not Issued	161	05/23/1990	STABILIZED SPORE-FORMING VIABLE MICROORGANISMS PREPARATION, ITS PRODUCTION AND PELLET THEREOF	HASHIMOTO, KOJI
07592368	5123980	150	10/03/1990	SPUTTER DEPOSITED AMORPHOUS TITANIUM ALUMIUN ALLOYS	HASHIMOTO, KOJI
07593745	5041175	150	10/05/1990	AMORPHOUS ALUMINUM ALLOYS	HASHIMOTO, KOJI
<u>07662283</u>	Not Issued	161		AMORPHOUS ALLOY CATALYSTS FOR CONVERSION OF CARBON DIOXIDE	HASHIMOTO, КОЛ
07662286	Not Issued	161		AMORPHOUS ALLOY CATALYSTS FOR DECOMPOSITION OF FLONS	HASHIMOTO, КОЛ
<u>07758851</u>	Not Issued	161		CATALYST MATERIAL AND METHOD FOR DECOMPOSITION OF CHLOROFLUOROCARBONS	HASHIMOTO, KOJI
07766064	Not Issued	166	09/27/1991	GENE DETECTION METHOD	HASHIMOTO, KOJI
07779985	Not Issued	166	10/21/1991	AMORPHOUS ALUMINUM ALLOYS	HASHIMOTO, KOJI
07830847	5264498	250	02/04/1992	POLYCARBONATE RESIN COMPOSITION	HASHIMOTO, KOJI
07853436	<u>5468576</u>	150		METHOD FOR MANUFACTURING EXPOSURE MASK AND THE EXPOSURE MASK	HASHIMOTO, KOJI
<u>07856159</u>	5326736	250	04/01/1992	AMORPHOUS ALLOY CATALYSTS FOR CONVERSION OF EXHAUST GASES TO HARMLESS GASES	НАЅНІМОТО, КОЛ
07867127	5245112	250	HI I	METHOD FOR DECOMPOSITION OF CHLOROFLUORCARBONS	HASHIMOTO, KOJI
<u>07867527</u>	5283059	150		PROCESS FOR PRODUCING A STABILIZED STORE-FORMING VIABLE MICROORGANISMS PREPARATION CONTAINING BACILUS CEREUS	НАЅНІМОТО, КОЈІ

	1		1		
07869629	5220108	250	04/16/1992	AMORPHOUS ALLOY CATALYSTS FOR DECOMPOSITION OF FLONS	HASHIMOTO, KOJI
07878567	Not Issued	166	05/05/1992	_	HASHIMOTO, KOJI
07880047	<u>5217332</u>	150		DRILL BIT FOR ADVANCED MATERIALS	HASHIMOTO, KOJI
07892477	Not Issued	161	06/02/1992	HIGHLY CORROSION- RESISTANT AMORPHOUS ALLOY	НАЅНІМОТО, КОЈІ
<u>07913421</u>	5248754	150	07/15/1992	PROCESS FOR CONTINUOUS PRODUCTION OF POLYCARBONATE OLIGOMER	HASHIMOTO, KOJI
07914027	5634989	150	07/15/1992	•	HASHIMOTO, KOJI
<u>07955256</u>	5319324	150	10/01/1992	METHOD OF DIRECT BONDING OF CRYSTALS AND CRYSTAL DEVICES	HASHIMOTO, KOJI
07961783	Not Issued	166	10/15/1992	HIGH CORROSION RESISTANT AMORPHOUS ALLOYS	HASHIMOTO, KOJI
08007577	Not Issued	163		HIGHLY CORROSION RESISTANT AMORPHOUS ALUMINUM ALLOY	НАЅНІМОТО, КОЈІ
<u>08008758</u>	Not Issued	163	01/25/1993	HIGHLY CORROSION RESISTANT AMORPHOUS ALUMINUM ALLOY	HASHIMOTO, KOJI
08009397	Not Issued	161	11	AMORPHOUS ALUMINUM ALLOYS	HASHIMOTO, KOJI
08041427	5364711	150	03/31/1993	FUEL CELL	HASHIMOTO, KOJI
08044534	Not Issued	166	04/07/1993	AMORPHOUS ALLOYS RESISTANT AGAINST HOT CORROSION	HASHIMOTO, KOJI
08073623	Not Issued	166		1	HASHIMOTO, KOJI

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Inventor Name Search Result

Your Search was:

Last Name = USUI

First Name = SATOSHI

Application#	Patent#	=			Inventor Name
<u>06945298</u>	<u>4746536</u>	150	12/17/1986	METHOD FOR SELECTIVE CHEMICAL PLATING	USUI, SATOSHI
07987593	5328541	250	12/09/1992	METHOD OF WELDING TUBULAR PRODUCTS OF POLYARYLENE SULFIDE AND WELDED TUBULAR STRUCTURE	USUI, SATOSHI
08364693	Not Issued	161	12/28/1994	APPARATUS AND METHOD FOR WELDING THERMOPLASTIC RESIN MEMBERS	USUI, SATOSHI
<u>08365285</u>	Not Issued	161	12/28/1994	METHOD FOR WELDING TUBULAR MEMBERS	USUI, SATOSHI
08370485	Not Issued	161	01/09/1995	APPARATUS AND METHOD FOR WELDING TUBULAR MEMBERS	USUI, SATOSHI
<u>09137684</u>	6136478	150	08/21/1998	MASK PATTERN CORRECTION METHOD AND EXPOSURE MASK TO BE USED FOR SUCH A METHOD	USUI, SATOSHI
<u>09155546</u>	Not Issued	164	09/25/1998	RESIN COMPOSITION	USUI, SATOSHI
09650672	6526250	150		TRANSFER FIXING DEVICE, IMAGE BEARING AND CONVEYING BODY, AND IMAGE FORMING APPARATUS	USUI, SATOSHI
09662219	Not Issued	71	09/14/2000	Pattern correcting method of mask for manufacturing a semiconductor device and recording medium having recorded its pattern correcting method	
09815004	<u>6727026</u>	150	03/23/2001	SEMICONDUCTOR	USUI, SATOSHI

1		1			
				INTEGRATED CIRCUIT PATTERNS	
09985810	6617083	150	11	METHOD OF CORRECTING MASK PATTERNS	USUI, SATOSHI
10084386	Not Issued	164	02/28/2002	HIGH PRESSURE FUEL PUMP FOR INTERNAL COMBUSTION ENGINE	USUI, SATOSHI
<u>10127770</u>	6622296	150	04/23/2002	EXPOSURE MASK PATTERN CORRECTION METHOD, PATTERN FORMATION METHOD, AND A PROGRAM PRODUCT FOR OPERATING A COMPUTER	USUI, SATOSHI
10274034	7165534	150	10/21/2002	FUEL FEED SYSTEM	USUI, SATOSHI
10442203	7152583	150	05/21/2003	HIGH-PRESSURE FUEL PUMP	USUI, SATOSHI
10614206	Not Issued	161	07/08/2003	HIGH PRESSURE FUEL PUMP FOR INTERNAL COMBUSTION ENGINE	USUI, SATOSHI
10896039	7124738	150	07/22/2004	DAMPER MECHANISM AND HIGH PRESSURE FUEL PUMP	USUI, SATOSHI
<u>10975001</u>	Not Issued	30	10/28/2004	Image information processing system, image information processing apparatus, image information outputting method, code information processing apparatus and program thereof	USUI, SATOSHI
10975412	Not Issued	30	10/29/2004	Image outputting system, image processing apparatus, image processing method and program thereof	USUI, SATOSHI
11217444	Not Issued	61	09/02/2005	Controlling apparatus of variable capacity type fuel pump and fuel supply system	USUI, SATOSHI
11219674	Not Issued	30	09/07/2005	Index sheet, picture case, image processing apparatus, image processing method and storage medium storing program	USUI, SATOSHI
11354851	Not Issued	61	02/16/2006	Electromagnetic drive mechanism and a high-pressure fuel supply pump	USUI, SATOSHI
11409062	Not Issued	20		High pressure fuel pump for internal combustion engine	USUI, SATOSHI
11546430	Not	41	10/12/2006	Damper mechanism and high	USUI, SATOSHI

	Issued	` .		pressure fuel pump	
<u>11582396</u>	Not Issued	41		High-pressure fuel supply system using variable displacement fuel pump	USUI, SATOSHI
11599468	Not Issued	25	11/15/2006	High-pressure fuel pump	USUI, SATOSHI
11622170	Not Issued	41		High pressure fuel pump provided with damper	USUI, SATOSHI
11,780940	Not Issued	17	07/20/2007	High-Pressure Fuel Pump	USUI, SATOSHI
11835544	Not Issued	19	08/08/2007	High-Pressure Fuel Supply Pump	USUI, SATOSHI

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Inventor Name Search Result

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Last Name = YOSHIKAWA

First Name = KEI

Application#	Patent#	Status	Date Filed	Title	Inventor Name
09662219	Not Issued		09/14/2000	Pattern correcting method of mask for manufacturing a semiconductor device and recording medium having recorded its pattern correcting method	YOSHIKAWA, KEI
10107298	7208423	150	03/28/2002	SEMICONDUCTOR DEVICE FABRICATION METHOD AND SEMICONDUCTOR DEVICE	YOSHIKAWA, KEI
11643907	Not Issued	30	12/22/2006	Semiconductor device fabrication method and semiconductor device	YOSHIKAWA, KEI
07470028	Not Issued	166	01/25/1990	AQUEOUS RESIN COMPOSITION	YOSHIKAWA, KEIGO
07884882	Not Issued	161		AQUEOUS RESIN COMPOSITION	YOSHIKAWA, KEIGO
06592588	4566163	150		AUTOMATIC SUPERVISORY SYSTEM FOR A WARPER	YOSHIKAWA, KEIJI
07823364	5242224	150		TEMPERATURE MONITORING UNIT	YOSHIKAWA, KEIJI
<u>09763130</u>	6452056	250		PROCESS FOR THE PREPARATION OF FLUOROBENZYL DERIVATIVES	YOSHIKAWA, KEISUKE
09897077	6756793	150	,	CAPACITANCE TYPE MOISTURE SENSOR AND METHOD OF PRODUCING THE SAME	YOSHIKAWA, KEISUKE
10781947	7064011	150	02/20/2004	SEMICONDUCTOR DEVICE FABRICATING APPARATUS AND SEMICONDUCTOR DEVICE FABRICATING	YOSHIKAWA, KEISUKE

	11	I	 	METHOD	ı
11000905	7268191	150	12/02/2004	METHOD FOR PRODUCING EPOXY RESIN COMPOSITION FOR SEMICONDUCTOR ENCAPSULATION AND EPOXY RESIN COMPOSITION FOR SEMICONDUCTOR ENCAPSULATION AND SEMICONDUCTOR ENCAPSULATION AND SEMICONDUCTOR DEVICE OBTAINED THEREBY	YOSHIKAWA, KEISUKE
<u>11012126</u>	7132755	150	12/16/2004	ADHESIVE FILM FOR MANUFACTURING SEMICONDUCTOR DEVICE	YOSHIKAWA, KEISUKE
11115307	7262514	150	04/27/2005	EPOXY RESIN COMPOSITION FOR SEMICONDUCTOR ENCAPSULATION, SEMICONDUCTOR DEVICE USING THE SAME, AND PROCESS FOR PRODUCING SEMICONDUCTOR DEVICE	YOSHIKAWA, KEISUKE
11362783	Not Issued	61	02/28/2006	Semiconductor device fabricating apparatus and semiconductor device fabricating method	YOSHIKAWA, KEISUKE
11632348	Not Issued	30	03/05/2007	Semiconductor Device, Substrate for Producing Semiconductor Device and Method of Producing Them	KEISUKE
09117599	6155380	150	07/31/1998	GREASE FILLING DEVICE FOR ELECTRIC MOTOR	YOSHIKAWA, KEIZO
<u>09117600</u>	Not Issued	161		BEARING CLEANING DEVICE FOR ELECTRIC MOTOR	YOSHIKAWA, KEIZO

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